

<b>Notice of References Cited</b>	Application/Control No. 10/617,776	Applicant(s)/Patent Under Reexamination LI, NIEN-LUN	
	Examiner Thomas R. Hannon	Art Unit 3682	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,626,577 B1	09-2003	Horng et al.	384/292
	B	US-6,494,621 B2	12-2002	Markovitch, Peter T.	384/292
	C	US-2002/0172609 A1	11-2002	Hsieh, Hsin-Mao	417/423.7
	D	US-5,932,946 A	08-1999	Miyasaka et al.	384/279
	E	US-5,630,953	05-1997	Klink, Ulrich	219/121.69
	F	US-4,105,267	08-1978	Mori, Sanae	384/291
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.